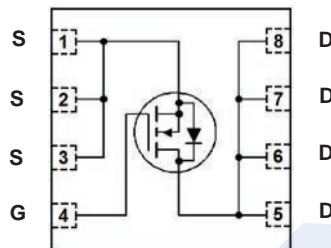


## N-Channel MOSFET

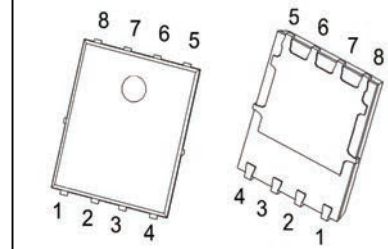
## 2KK5132DFN

## ■ Features

- $V_{DS} = 30\text{ V}$
- $I_D$  (at  $V_{GS}=10\text{V}$ ) = 60 A
- $R_{DS(ON)}$  (at  $V_{GS} = 10\text{ V}$ ) < 5.2 m $\Omega$
- $R_{DS(ON)}$  (at  $V_{GS} = 4.5\text{ V}$ ) < 8.6 m $\Omega$
- 100% UIS Tested
- 100%  $R_g$  Tested



PDFN5x6-8

■ Absolute Maximum Ratings ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

| Parameter   | Symbol          | Rating                    | Unit               |     |
|---|-----------------|---------------------------|--------------------|-----|
| Drain-Source Voltage                              | $V_{DS}$        | 30                        | V                  |     |
| Gate-Source Voltage                               | $V_{GS}$        | $\pm 20$                  |                    |     |
| Continuous Drain Current                          | $I_D$           | $T_C = 25^\circ\text{C}$  | A                  |     |
|   |                 | $T_C = 100^\circ\text{C}$ |                    | 39  |
| Pulsed Drain Current (Note 2)                     | $I_{DM}$        | 100                       |                    |     |
| Continuous Drain Current                          | $I_{DSM}$       | $T_A = 25^\circ\text{C}$  |                    | 27  |
|   |                 | $T_A = 70^\circ\text{C}$  | 22                 |     |
| Avalanche Current (Note 2)                        | $I_{AS}$        | 38                        | A                  |     |
| Avalanche Energy $L = 0.05\text{mH}$ (Note 2)     | $E_{AS}$        | 7                         | mJ                 |     |
| Thermal Resistance, Junction- to-Ambient (Note 5) | $R_{\theta JA}$ | 50                        | $^\circ\text{C/W}$ |     |
| Thermal Resistance, Junction- to-Case             | $R_{\theta JC}$ | 4                         |                    |     |
| Power Dissipation (Note 4)                        | $P_D$           | $T_C = 25^\circ\text{C}$  | W                  |     |
|   |                 | $T_C = 100^\circ\text{C}$ |                    | 13  |
| Power Dissipation (Note 5)                        | $P_{DSM}$       | $T_A = 25^\circ\text{C}$  |                    | 6.2 |
|   |                 | $T_A = 70^\circ\text{C}$  |                    | 4   |
| Junction Temperature                              | $T_J$           | 150                       | $^\circ\text{C}$   |     |
| Storage Temperature Range                         | $T_{stg}$       | -55 to 150                |                    |     |

Notes:

1. The maximum current rating is package limited.
2. Single pulse width limited by junction temperature  $T_{J(MAX)}=150^\circ\text{C}$ .
3. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
4. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
5. The value of  $R_{\theta JA}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA} t \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

## N-Channel MOSFET

## 2KK5132DFN

■ Electrical Characteristics (T<sub>J</sub> = 25°C unless otherwise specified)

| Parameter                                 | Symbol              | Test Conditions   | Min             | Typ  | Max  | Unit |    |
|---|---------------------|---|-----------------|------|------|------|----|
| <b>Static Characteristics</b>             |                     |   |                 |      |      |      |    |
| Drain-Source Breakdown Voltage            | BV <sub>DSS</sub>   | I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0V   | 30              |      |      | V    |    |
| Zero Gate Voltage Drain Current           | I <sub>DSS</sub>    | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V   |                 |      | 1    | μA   |    |
|   |                     | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> =55°C                               |                 |      | 5    |      |    |
| Gate to Source Leakage Current            | I <sub>GSS</sub>    | V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20 V  |                 |      | ±100 | nA   |    |
| Gate to Source Threshold Voltage          | V <sub>GS(th)</sub> | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA  | 1.1             |      | 2.2  | V    |    |
| Static Drain-Source On-Resistance         | R <sub>DS(on)</sub> | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A   |                 | 4.3  | 5.2  | mΩ   |    |
|   |                     | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A, T <sub>J</sub> =125°C                              |                 | 6.3  | 7.6  |      |    |
|   |                     | V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 20 A  |                 | 6.8  | 8.6  |      |    |
| Forward Transconductance                  | g <sub>FS</sub>     | V <sub>DS</sub> = 5 V, I <sub>D</sub> = 20 A  |                 | 67   |      | S    |    |
| <b>Dynamic Characteristics</b>            |                     |   |                 |      |      |      |    |
| Input Capacitance                         | C <sub>iss</sub>    | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15 V,<br>f = 1 MHz                                       |                 | 820  |      | pF   |    |
| Output Capacitance                        | C <sub>oss</sub>    |   |                 | 340  |      |      |    |
| Reverse Transfer Capacitance              | C <sub>rss</sub>    |   |                 | 40   |      |      |    |
| Gate Resistance                           | R <sub>g</sub>      | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f = 1MHz  | 0.6             | 1.2  | 1.8  | Ω    |    |
| <b>Switching Characteristics</b>          |                     |   |                 |      |      |      |    |
| Total Gate Charge (10V)                   | Q <sub>g</sub>      | V <sub>GS</sub> = 10V, V <sub>DS</sub> = 15 V,<br>I <sub>D</sub> = 20 A                           |                 | 13   |      | nC   |    |
| Total Gate Charge (4.5V)                  |                     |   |                 | 6.1  |      |      |    |
| Gate Source Charge                        |                     |   | Q <sub>gs</sub> |      | 2    |      |    |
| Gate Drain Charge                         |                     |   | Q <sub>gd</sub> |      | 2.4  |      |    |
| Turn-On DelayTime                         | t <sub>d(on)</sub>  | V <sub>GS</sub> = 10V, V <sub>DS</sub> = 15 V,<br>R <sub>L</sub> = 0.75 Ω, R <sub>GEN</sub> = 3 Ω |                 | 6.5  |      | ns   |    |
| Turn-On Rise Time                         | t <sub>r</sub>      |   |                 | 16.5 |      |      |    |
| Turn-Off DelayTime                        | t <sub>d(off)</sub> |   |                 | 17   |      |      |    |
| Turn-Off Fall Time                        | t <sub>f</sub>      |   |                 | 2.5  |      |      |    |
| <b>Drain-Source Diode Characteristics</b> |                     |   |                 |      |      |      |    |
| Body Diode Reverse Recovery Time          | t <sub>rr</sub>     | I <sub>F</sub> = 20A, di/dt = 500 A/μs  |                 | 11   |      | ns   |    |
| Body Diode Reverse Recovery Charge        | Q <sub>rr</sub>     |   |                 |      | 19   |      | nC |
| Maximum Body-Diode Continuous Current     | I <sub>S</sub>      | (Note 1)  |                 |      | 30   | A    |    |
| Diode Forward Voltage                     | V <sub>SD</sub>     | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1 A   |                 | 0.7  | 1    | V    |    |

Notes:

- The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.
- These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.
- These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.

## ■ Marking

|         |                |
|---------|----------------|
| Marking | K5132<br>KC*** |
|---------|----------------|

# N-Channel MOSFET

## 2KK5132DFN

### Typical Electrical and Thermal Characteristics

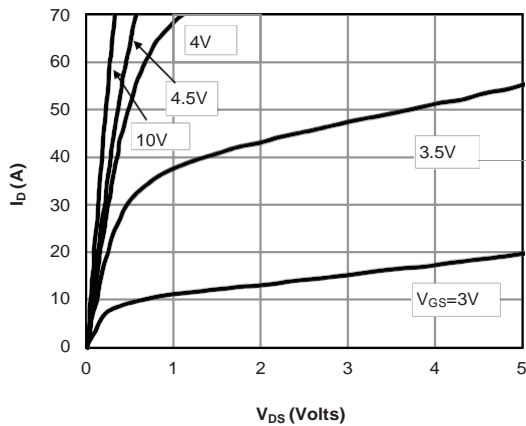


Figure 1: On-Region Characteristics (Note E)

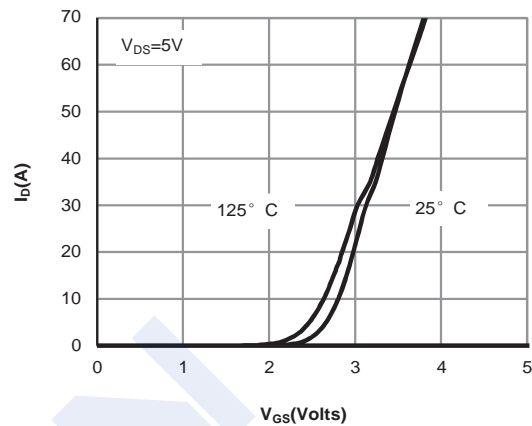


Figure 2: Transfer Characteristics (Note E)

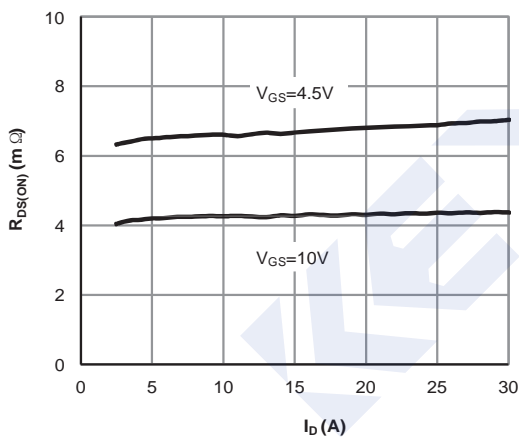


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

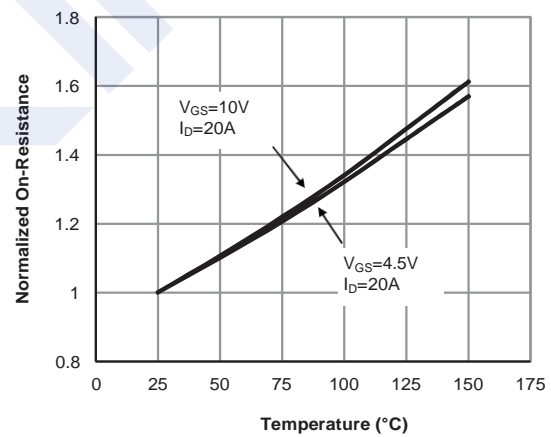


Figure 4: On-Resistance vs. Junction Temperature (Note E)

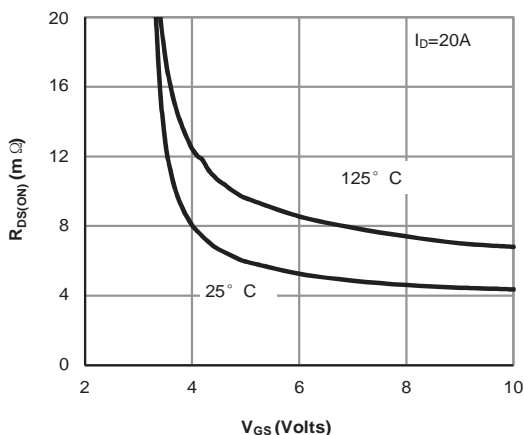


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

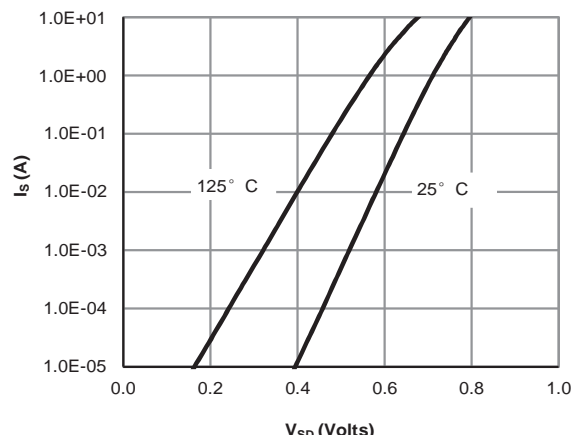


Figure 6: Body-Diode Characteristics (Note E)

# N-Channel MOSFET

## 2KK5132DFN

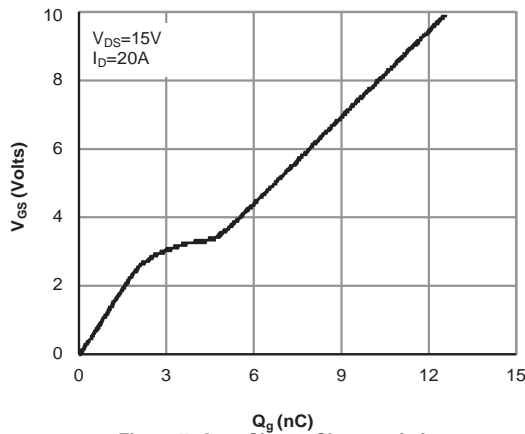


Figure 7: Gate-Charge Characteristics

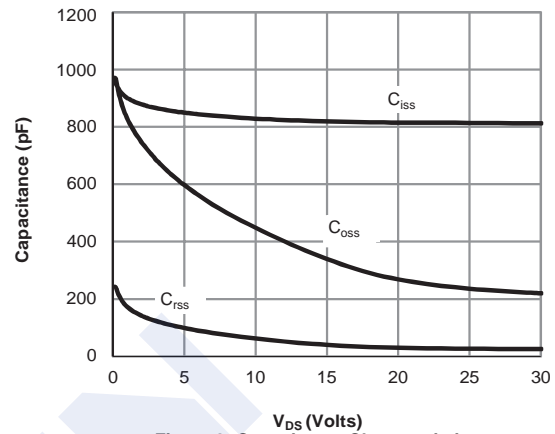


Figure 8: Capacitance Characteristics

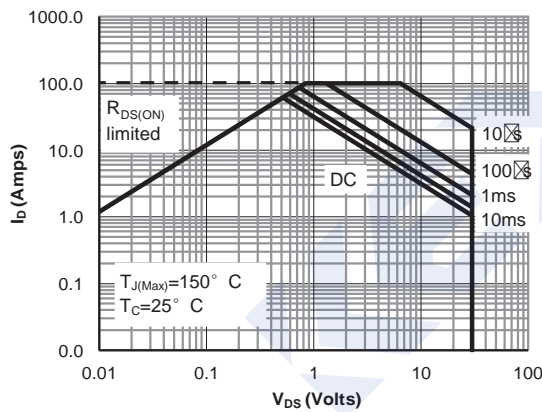


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

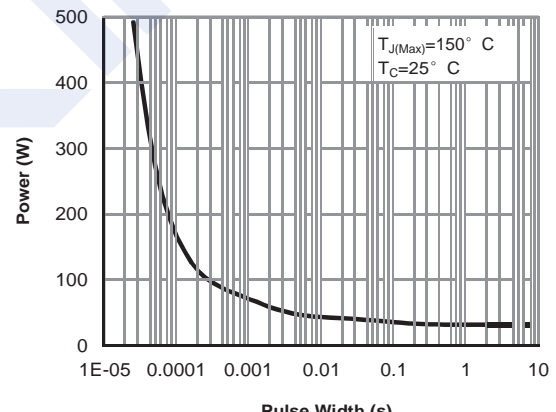


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

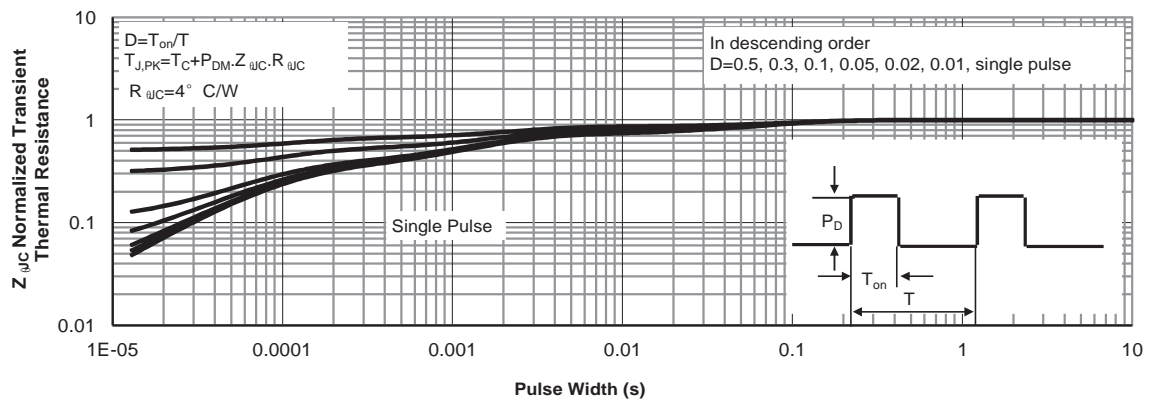


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

# N-Channel MOSFET

## 2KK5132DFN

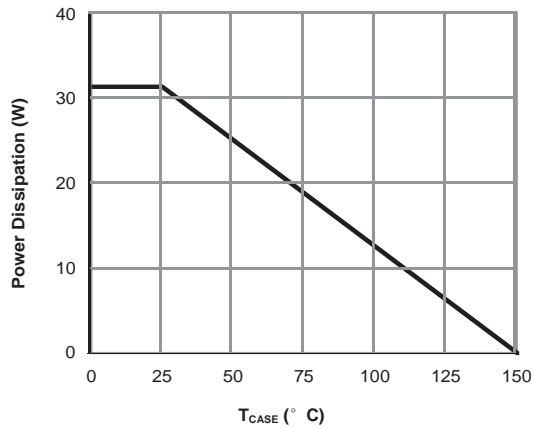


Figure 12: Power De-rating (Note F)

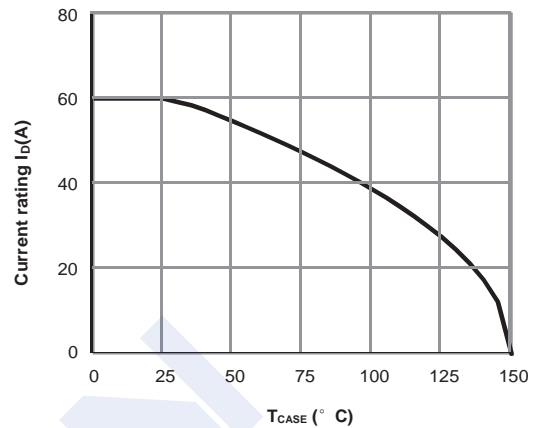


Figure 13: Current De-rating (Note F)

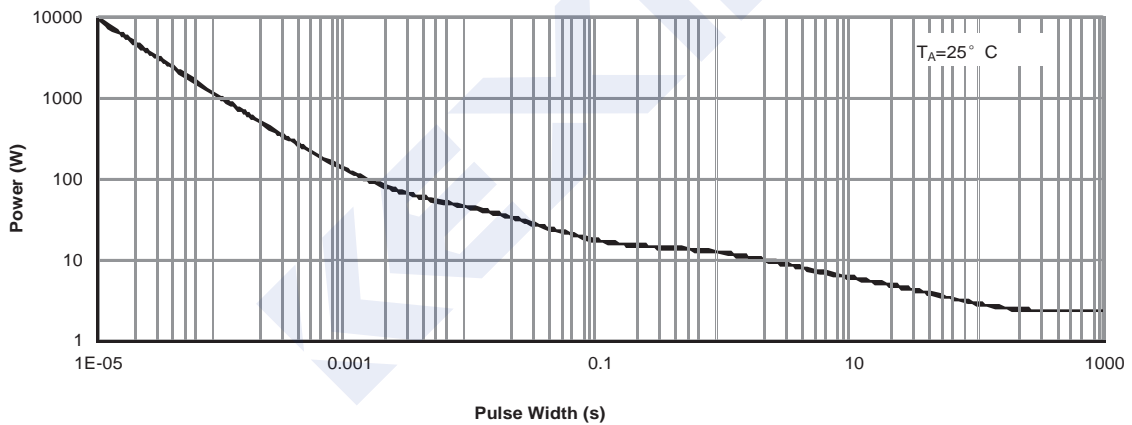


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

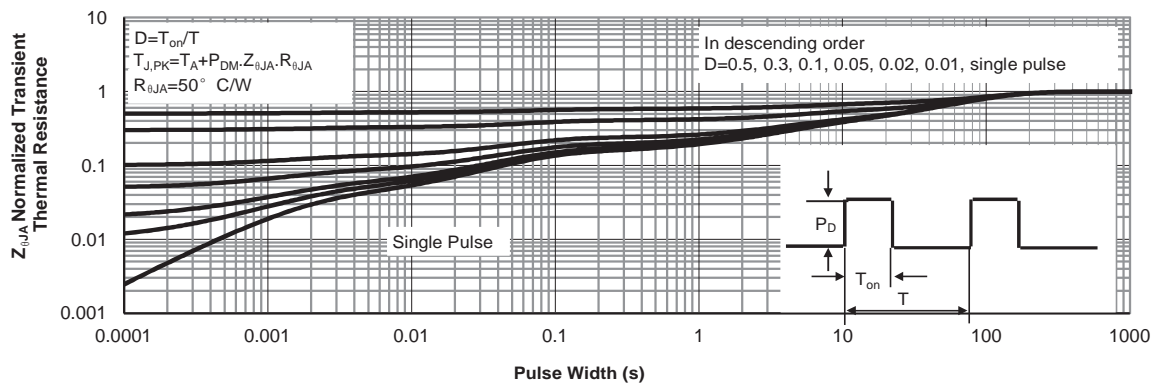
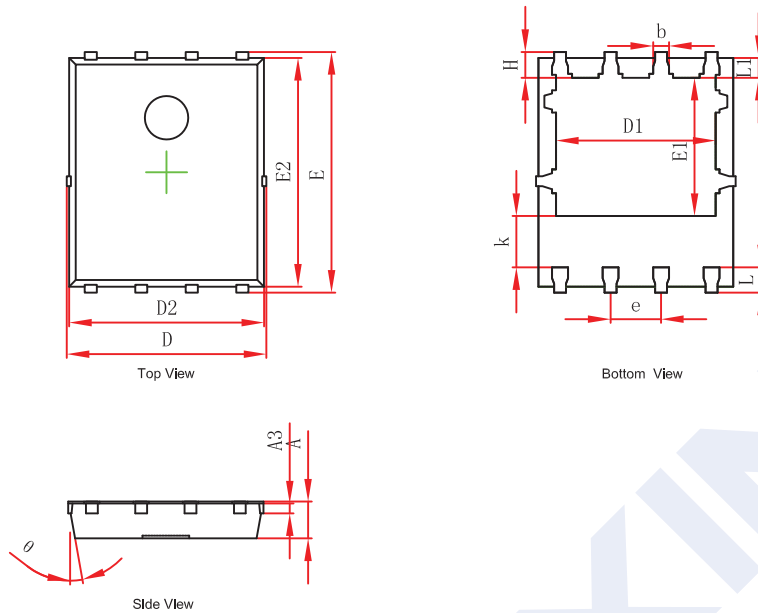


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

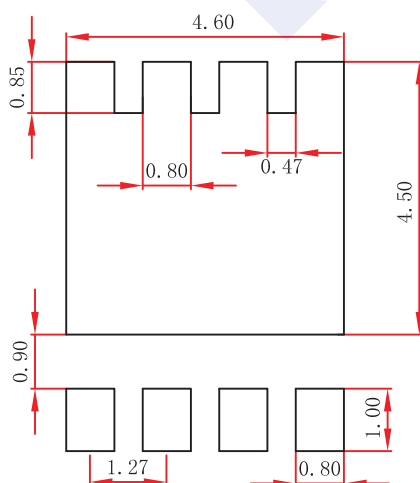
## N-Channel MOSFET

## 2KK5132DFN

## ■ PDFN5x6-8 Package Outline Dimensions



## ■ PDFN5x6-8 Suggested Pad Layout



## Note:

1. Controlling dimension: in millimeters.
2. General tolerance:  $\pm 0.05\text{mm}$ .
3. The pad layout is for reference purposes only.